

EasyPACK™ module with CoolSiC™ Trench MOSFET and PressFIT / NTC / TIM

Features

- Electrical features
 - $V_{DSS} = 1200 \text{ V}$
 - $I_{DN} = 100 \text{ A} / I_{DRM} = 200 \text{ A}$
 - High current density
 - Low switching losses
- Mechanical features
 - Rugged mounting due to integrated mounting clamps
 - Integrated NTC temperature sensor
 - PressFIT contact technology
 - Pre-applied thermal interface material



Typical appearance

Potential applications

- Solar applications
- Three-level applications
- DC charger for EV

Product validation

- Qualified for industrial applications according to the relevant tests of IEC 60747, 60749 and 60068

Description

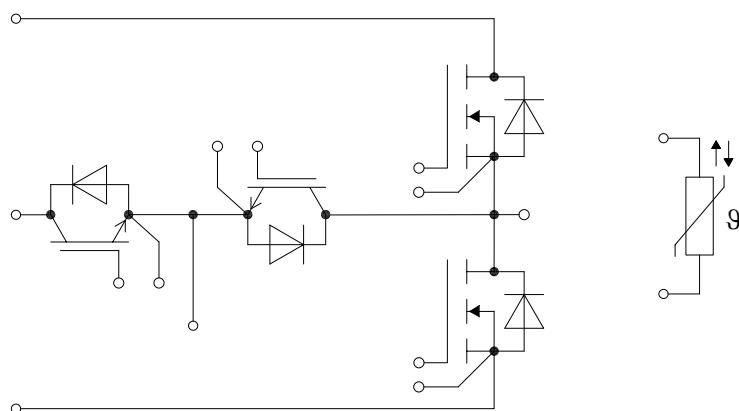


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1 Package

Table 1 Insulation coordination

Parameter	Symbol	Note or test condition	Values	Unit
Isolation test voltage	V_{ISOL}	RMS, $f = 50 \text{ Hz}$, $t = 60 \text{ s}$	3.0	kV
Internal isolation		basic insulation (class 1, IEC 61140)	Al_2O_3	
Creepage distance	d_{Creep}	terminal to heatsink	11.5	mm
Creepage distance	d_{Creep}	terminal to terminal	6.3	mm
Clearance	d_{Clear}	terminal to heatsink	10.0	mm
Clearance	d_{Clear}	terminal to terminal	5.0	mm
Comparative tracking index	CTI		>200	
Relative thermal index (electrical)	RTI	housing	140	°C

Table 2 Characteristic values

Parameter	Symbol	Note or test condition	Values			Unit
			Min.	Typ.	Max.	
Stray inductance module	L_{sCE}			12		nH
Module lead resistance, terminals - chip	$R_{CC'EE'}$	$T_H=25^\circ\text{C}$, per switch		0.4		mΩ
Storage temperature	T_{stg}		-40		125	°C
Maximum baseplate operation temperature	T_{BPmax}				125	°C
Mounting force per clamp	F		40		80	N
Weight	G			39		g

Note: The current under continuous operation is limited to 25 A rms per connector pin.

Storage and shipment of modules with TIM => see AN2012-07.

2 MOSFET

Table 3 Maximum rated values

Parameter	Symbol	Note or test condition		Values	Unit
Drain-source voltage	V_{DSS}	$T_{vj} = 25^\circ\text{C}$		1200	V
Implemented drain current	I_{DN}			100	A
Continuous DC drain current	I_{DDC}	$T_{vj} = 175^\circ\text{C}$, $V_{GS} = 18 \text{ V}$	$T_H = 65^\circ\text{C}$	85	A
Repetitive peak drain current	I_{DRM}	verified by design, t_p limited by T_{vjmax}		200	A

(table continues...)

Table 3 (continued) Maximum rated values

Parameter	Symbol	Note or test condition	Values	Unit
Gate-source voltage, max. transient voltage	V_{GS}	$D < 0.01$	-10/23	V
Gate-source voltage, max. static voltage	V_{GS}		-7/20	V

Table 4 Recommended values

Parameter	Symbol	Note or test condition	Values	Unit
On-state gate voltage	$V_{GS(on)}$		15...18	V
Off-state gate voltage	$V_{GS(off)}$		-5...0	V

Table 5 Characteristic values

Parameter	Symbol	Note or test condition	Values			Unit
			Min.	Typ.	Max.	
Drain-source on-resistance	$R_{DS(on)}$	$I_D = 100 \text{ A}$	$V_{GS} = 18 \text{ V}, T_{vj} = 25^\circ\text{C}$		8.1	12
			$V_{GS} = 18 \text{ V}, T_{vj} = 125^\circ\text{C}$		13.1	
			$V_{GS} = 18 \text{ V}, T_{vj} = 175^\circ\text{C}$		17.4	
			$V_{GS} = 15 \text{ V}, T_{vj} = 25^\circ\text{C}$		9.7	
Gate threshold voltage	$V_{GS(th)}$	$I_D = 40 \text{ mA}, V_{DS} = V_{GS}, T_{vj} = 25^\circ\text{C}$, (tested after 1ms pulse at $V_{GS} = +20 \text{ V}$)	3.45	4.3	5.15	V
Total gate charge	Q_G	$V_{DS} = 800 \text{ V}, V_{GS} = -3/18 \text{ V}$		0.297		μC
Internal gate resistor	R_{Gint}	$T_{vj} = 25^\circ\text{C}$		2.1		Ω
Input capacitance	C_{ISS}	$f = 100 \text{ kHz}, V_{DS} = 800 \text{ V}, V_{GS} = 0 \text{ V}$	$T_{vj} = 25^\circ\text{C}$		8.8	nF
Output capacitance	C_{OSS}	$f = 100 \text{ kHz}, V_{DS} = 800 \text{ V}, V_{GS} = 0 \text{ V}$	$T_{vj} = 25^\circ\text{C}$		0.42	nF
Reverse transfer capacitance	C_{rss}	$f = 100 \text{ kHz}, V_{DS} = 800 \text{ V}, V_{GS} = 0 \text{ V}$	$T_{vj} = 25^\circ\text{C}$		0.028	nF
C_{OSS} stored energy	E_{OSS}	$V_{DS} = 800 \text{ V}, V_{GS} = -3/18 \text{ V}, T_{vj} = 25^\circ\text{C}$		172		μJ
Drain-source leakage current	I_{DSS}	$V_{DS} = 1200 \text{ V}, V_{GS} = -3 \text{ V}$	$T_{vj} = 25^\circ\text{C}$	0.06	380	μA
Gate-source leakage current	I_{GSS}	$V_{DS} = 0 \text{ V}, T_{vj} = 25^\circ\text{C}$	$V_{GS} = 20 \text{ V}$		400	nA

(table continues...)

Table 5 (continued) Characteristic values

Parameter	Symbol	Note or test condition	Values			Unit
			Min.	Typ.	Max.	
Turn-on delay time (inductive load)	$t_{d\ on}$	$I_D = 100 \text{ A}$, $R_{Gon} = 15 \Omega$, $V_{DS} = 400 \text{ V}$, $V_{GS} = -3/18 \text{ V}$	$T_{vj} = 25^\circ\text{C}$		83	ns
			$T_{vj} = 125^\circ\text{C}$		73	
			$T_{vj} = 175^\circ\text{C}$		70	
Rise time (inductive load)	t_r	$I_D = 100 \text{ A}$, $R_{Gon} = 15 \Omega$, $V_{DS} = 400 \text{ V}$, $V_{GS} = -3/18 \text{ V}$	$T_{vj} = 25^\circ\text{C}$		106	ns
			$T_{vj} = 125^\circ\text{C}$		111	
			$T_{vj} = 175^\circ\text{C}$		116	
Turn-off delay time (inductive load)	$t_{d\ off}$	$I_D = 100 \text{ A}$, $R_{Goff} = 3.3 \Omega$, $V_{DS} = 400 \text{ V}$, $V_{GS} = -3/18 \text{ V}$	$T_{vj} = 25^\circ\text{C}$		74	ns
			$T_{vj} = 125^\circ\text{C}$		80	
			$T_{vj} = 175^\circ\text{C}$		84	
Fall time (inductive load)	t_f	$I_D = 100 \text{ A}$, $R_{Goff} = 3.3 \Omega$, $V_{DS} = 400 \text{ V}$, $V_{GS} = -3/18 \text{ V}$	$T_{vj} = 25^\circ\text{C}$		17	ns
			$T_{vj} = 125^\circ\text{C}$		16	
			$T_{vj} = 175^\circ\text{C}$		16	
Turn-on energy loss per pulse	E_{on}	$I_D = 100 \text{ A}$, $V_{DS} = 400 \text{ V}$, $L_\sigma = 27 \text{ nH}$, $V_{GS} = -3/18 \text{ V}$, $R_{Gon} = 15 \Omega$, $di/dt = 2 \text{ kA}/\mu\text{s}$ ($T_{vj} = 175^\circ\text{C}$)	$T_{vj} = 25^\circ\text{C}$		3.28	mJ
			$T_{vj} = 125^\circ\text{C}$		3.97	
			$T_{vj} = 175^\circ\text{C}$		4.33	
Turn-off energy loss per pulse	E_{off}	$I_D = 100 \text{ A}$, $V_{DS} = 400 \text{ V}$, $L_\sigma = 27 \text{ nH}$, $V_{GS} = -3/18 \text{ V}$, $R_{Goff} = 3.3 \Omega$, $dv/dt = 20.1 \text{ kV}/\mu\text{s}$ ($T_{vj} = 175^\circ\text{C}$)	$T_{vj} = 25^\circ\text{C}$		0.32	mJ
			$T_{vj} = 125^\circ\text{C}$		0.38	
			$T_{vj} = 175^\circ\text{C}$		0.42	
Thermal resistance, junction to heat sink	R_{thJH}	per MOSFET, Valid with IFX pre-applied Thermal Interface Material			0.581	K/W
Temperature under switching conditions	$T_{vj\ op}$			-40	175	°C

Note: The selection of positive and negative gate-source voltages impacts the long-term behavior of the MOSFET and body diode. The design guidelines described in Application Note AN 2018-09 must be considered to ensure sound operation of the device over the planned lifetime.

$T_{vj\ op} > 150^\circ\text{C}$ is allowed for operation at overload conditions for MOSFET and body diode. For detailed specifications, please refer to AN 2021-13.

3 Body diode

Table 6 Maximum rated values

Parameter	Symbol	Note or test condition		Values	Unit
DC body diode forward current	I_{SD}	$T_{vj} = 175^\circ\text{C}$, $V_{GS} = -3 \text{ V}$	$T_H = 65^\circ\text{C}$	32	A

Table 7 Characteristic values

Parameter	Symbol	Note or test condition	Values			Unit
			Min.	Typ.	Max.	
Forward voltage	V_{SD}	$I_{SD} = 100 \text{ A}, V_{GS} = -3 \text{ V}$	$T_{vj} = 25 \text{ }^\circ\text{C}$		4.2	5.35
			$T_{vj} = 125 \text{ }^\circ\text{C}$		3.9	
			$T_{vj} = 175 \text{ }^\circ\text{C}$		3.8	

4 IGBT, 3-Level

Table 8 Maximum rated values

Parameter	Symbol	Note or test condition		Values		Unit
Collector-emitter voltage	V_{CES}			$T_{vj} = 25 \text{ }^\circ\text{C}$	650	V
Implemented collector current	I_{CN}				200	A
Continuous DC collector current	I_{CDC}	$T_{vj \max} = 175 \text{ }^\circ\text{C}$	$T_H = 65 \text{ }^\circ\text{C}$		90	A
Repetitive peak collector current	I_{CRM}	t_p limited by $T_{vj \text{ op}}$			200	A
Gate-emitter peak voltage	V_{GES}				± 20	V

Table 9 Characteristic values

Parameter	Symbol	Note or test condition	Values			Unit
			Min.	Typ.	Max.	
Collector-emitter saturation voltage	$V_{CE \text{ sat}}$	$I_C = 100 \text{ A}, V_{GE} = 15 \text{ V}$	$T_{vj} = 25 \text{ }^\circ\text{C}$	0.74	1.17	1.59
			$T_{vj} = 125 \text{ }^\circ\text{C}$		1.20	
			$T_{vj} = 150 \text{ }^\circ\text{C}$		1.21	
Gate threshold voltage	$V_{GE \text{ th}}$	$I_C = 2 \text{ mA}, V_{CE} = V_{GE}, T_{vj} = 25 \text{ }^\circ\text{C}$		3.25	4	4.75
Gate charge	Q_G	$V_{GE} = \pm 15 \text{ V}, V_{CE} = 400 \text{ V}$			0.84	
Internal gate resistor	R_{Gint}	$T_{vj} = 25 \text{ }^\circ\text{C}$			0	Ω
Input capacitance	C_{ies}	$f = 100 \text{ kHz}, T_{vj} = 25 \text{ }^\circ\text{C}, V_{CE} = 25 \text{ V}, V_{GE} = 0 \text{ V}$			14.3	nF
Reverse transfer capacitance	C_{res}	$f = 100 \text{ kHz}, T_{vj} = 25 \text{ }^\circ\text{C}, V_{CE} = 25 \text{ V}, V_{GE} = 0 \text{ V}$			0.05	nF
Collector-emitter cut-off current	I_{CES}	$V_{CE} = 650 \text{ V}, V_{GE} = 0 \text{ V}$	$T_{vj} = 25 \text{ }^\circ\text{C}$			1 mA
Gate-emitter leakage current	I_{GES}	$V_{CE} = 0 \text{ V}, V_{GE} = 20 \text{ V}, T_{vj} = 25 \text{ }^\circ\text{C}$			100 nA	
Turn-on delay time (inductive load)	t_{don}	$I_C = 100 \text{ A}, V_{CE} = 400 \text{ V}, V_{GE} = \pm 15 \text{ V}, R_{Gon} = 2.7 \Omega$	$T_{vj} = 25 \text{ }^\circ\text{C}$		0.014	
			$T_{vj} = 125 \text{ }^\circ\text{C}$		0.015	
			$T_{vj} = 150 \text{ }^\circ\text{C}$		0.015	

(table continues...)

Table 9 (continued) Characteristic values

Parameter	Symbol	Note or test condition	Values			Unit
			Min.	Typ.	Max.	
Rise time (inductive load)	t_r	$I_C = 100 \text{ A}$, $V_{CE} = 400 \text{ V}$, $V_{GE} = \pm 15 \text{ V}$, $R_{Gon} = 2.7 \Omega$	$T_{vj} = 25^\circ\text{C}$		0.009	μs
			$T_{vj} = 125^\circ\text{C}$		0.010	
			$T_{vj} = 150^\circ\text{C}$		0.011	
Turn-off delay time (inductive load)	t_{doff}	$I_C = 100 \text{ A}$, $V_{CE} = 400 \text{ V}$, $V_{GE} = \pm 15 \text{ V}$, $R_{Goff} = 39 \Omega$	$T_{vj} = 25^\circ\text{C}$		0.650	μs
			$T_{vj} = 125^\circ\text{C}$		0.680	
			$T_{vj} = 150^\circ\text{C}$		0.700	
Fall time (inductive load)	t_f	$I_C = 100 \text{ A}$, $V_{CE} = 400 \text{ V}$, $V_{GE} = \pm 15 \text{ V}$, $R_{Goff} = 39 \Omega$	$T_{vj} = 25^\circ\text{C}$		0.023	μs
			$T_{vj} = 125^\circ\text{C}$		0.045	
			$T_{vj} = 150^\circ\text{C}$		0.055	
Turn-on energy loss per pulse	E_{on}	$I_C = 100 \text{ A}$, $V_{CE} = 400 \text{ V}$, $L_\sigma = 27 \text{ nH}$, $V_{GE} = \pm 15 \text{ V}$, $R_{Gon} = 2.7 \Omega$, $di/dt = 7600 \text{ A}/\mu\text{s}$ ($T_{vj} = 150^\circ\text{C}$)	$T_{vj} = 25^\circ\text{C}$		0.264	mJ
			$T_{vj} = 125^\circ\text{C}$		0.394	
			$T_{vj} = 150^\circ\text{C}$		0.438	
Turn-off energy loss per pulse	E_{off}	$I_C = 100 \text{ A}$, $V_{CE} = 400 \text{ V}$, $L_\sigma = 27 \text{ nH}$, $V_{GE} = \pm 15 \text{ V}$, $R_{Goff} = 39 \Omega$, $dv/dt = 4800 \text{ V}/\mu\text{s}$ ($T_{vj} = 150^\circ\text{C}$)	$T_{vj} = 25^\circ\text{C}$		1.7	mJ
			$T_{vj} = 125^\circ\text{C}$		2.05	
			$T_{vj} = 150^\circ\text{C}$		2.31	
Thermal resistance, junction to heat sink	R_{thJH}	per IGBT, Valid with IFX pre-applied Thermal Interface Material			0.723	K/W
Temperature under switching conditions	$T_{vj op}$		-40		150	°C

5 Diode, 3-Level

Table 10 Maximum rated values

Parameter	Symbol	Note or test condition		Values		Unit
Repetitive peak reverse voltage	V_{RRM}			650		V
Implemented forward current	I_{FN}			150		A
Continuous DC forward current	I_F			100		A
Repetitive peak forward current	I_{FRM}	$t_P = 1 \text{ ms}$		200		A
I^2t - value	I^2t	$V_R = 0 \text{ V}$, $t_P = 10 \text{ ms}$		$T_{vj} = 125^\circ\text{C}$	1270	A^2s
				$T_{vj} = 150^\circ\text{C}$	1480	

Table 11 Characteristic values

Parameter	Symbol	Note or test condition	Values			Unit
			Min.	Typ.	Max.	
Forward voltage	V_F	$I_F = 100 \text{ A}, V_{GE} = 0 \text{ V}$	$T_{vj} = 25^\circ\text{C}$	0.74	1.35	1.86
			$T_{vj} = 125^\circ\text{C}$		1.29	
			$T_{vj} = 150^\circ\text{C}$		1.25	
Peak reverse recovery current	I_{RM}	$I_F = 100 \text{ A}, V_R = 400 \text{ V}, V_{GE} = -15 \text{ V}, -di_F/dt = 2000 \text{ A}/\mu\text{s} (T_{vj} = 150^\circ\text{C})$	$T_{vj} = 25^\circ\text{C}$		64.2	
			$T_{vj} = 125^\circ\text{C}$		99.8	
			$T_{vj} = 150^\circ\text{C}$		114	
Recovered charge	Q_r	$I_F = 100 \text{ A}, V_R = 400 \text{ V}, V_{GE} = -15 \text{ V}, -di_F/dt = 2000 \text{ A}/\mu\text{s} (T_{vj} = 150^\circ\text{C})$	$T_{vj} = 25^\circ\text{C}$		3.99	
			$T_{vj} = 125^\circ\text{C}$		7.07	
			$T_{vj} = 150^\circ\text{C}$		9.8	
Reverse recovery energy	E_{rec}	$I_F = 100 \text{ A}, V_R = 400 \text{ V}, V_{GE} = -15 \text{ V}, -di_F/dt = 2000 \text{ A}/\mu\text{s} (T_{vj} = 150^\circ\text{C})$	$T_{vj} = 25^\circ\text{C}$		0.45	
			$T_{vj} = 125^\circ\text{C}$		1	
			$T_{vj} = 150^\circ\text{C}$		1.35	
Thermal resistance, junction to heat sink	R_{thJH}	per diode, Valid with IFX pre-applied Thermal Interface Material			0.802	K/W
Temperature under switching conditions	$T_{vj op}$		-40		150	°C

6 NTC-Thermistor

Table 12 Characteristic values

Parameter	Symbol	Note or test condition	Values			Unit
			Min.	Typ.	Max.	
Rated resistance	R_{25}	$T_{NTC} = 25^\circ\text{C}$		5		kΩ
Deviation of R_{100}	$\Delta R/R$	$T_{NTC} = 100^\circ\text{C}, R_{100} = 493 \Omega$	-5		5	%
Power dissipation	P_{25}	$T_{NTC} = 25^\circ\text{C}$			20	mW
B-value	$B_{25/50}$	$R_2 = R_{25} \exp[B_{25/50}(1/T_2 - 1/(298,15 \text{ K}))]$		3375		K
B-value	$B_{25/80}$	$R_2 = R_{25} \exp[B_{25/80}(1/T_2 - 1/(298,15 \text{ K}))]$		3411		K
B-value	$B_{25/100}$	$R_2 = R_{25} \exp[B_{25/100}(1/T_2 - 1/(298,15 \text{ K}))]$		3433		K

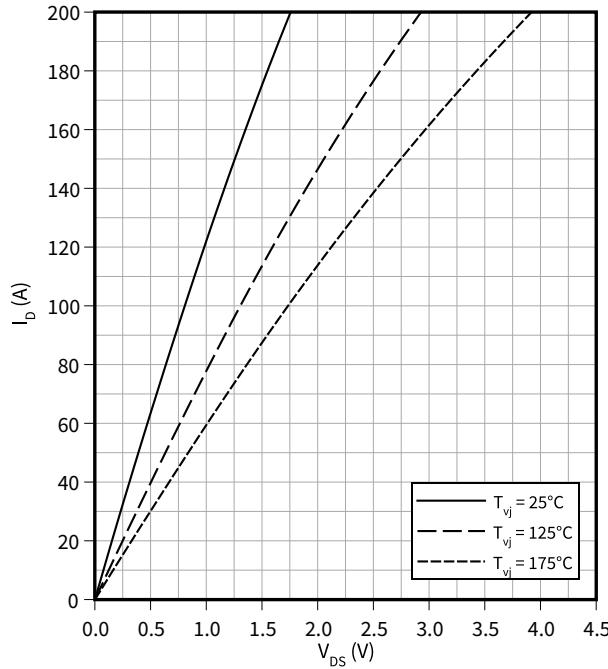
Note: Specification according to the valid application note.

7 Characteristics diagrams

output characteristic (typical), MOSFET

$$I_D = f(V_{DS})$$

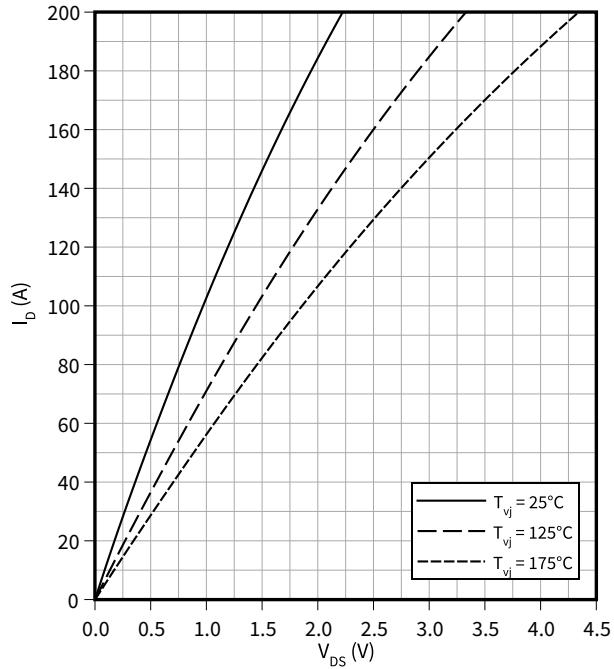
$$V_{GS} = 18 \text{ V}$$



output characteristic (typical), MOSFET

$$I_D = f(V_{DS})$$

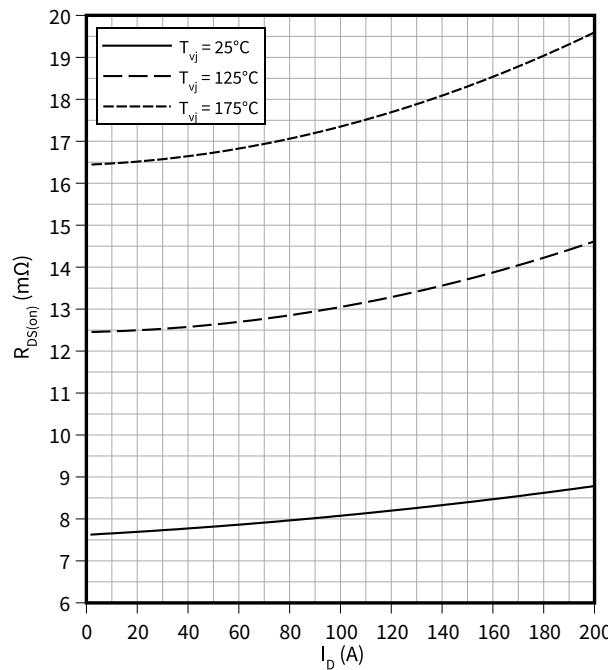
$$V_{GS} = 15 \text{ V}$$



Drain source on-resistance (typical), MOSFET

$$R_{DS(on)} = f(I_D)$$

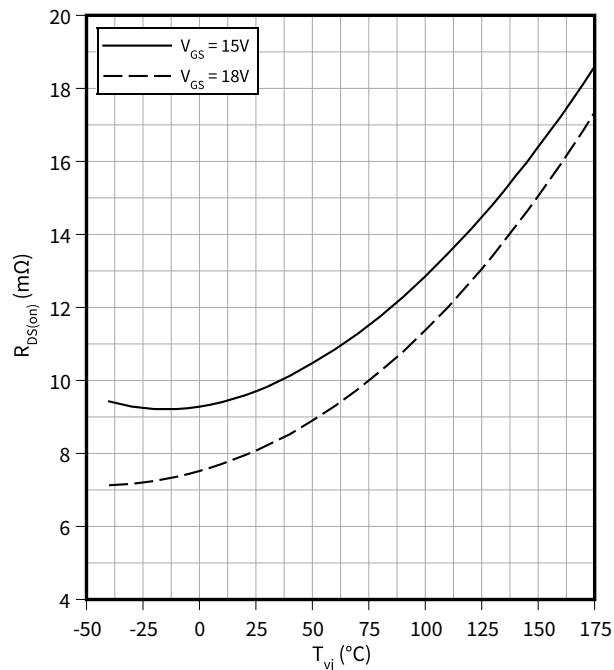
$$V_{GS} = 18 \text{ V}$$



Drain source on-resistance (typical), MOSFET

$$R_{DS(on)} = f(T_{vj})$$

$$I_D = 100 \text{ A}$$

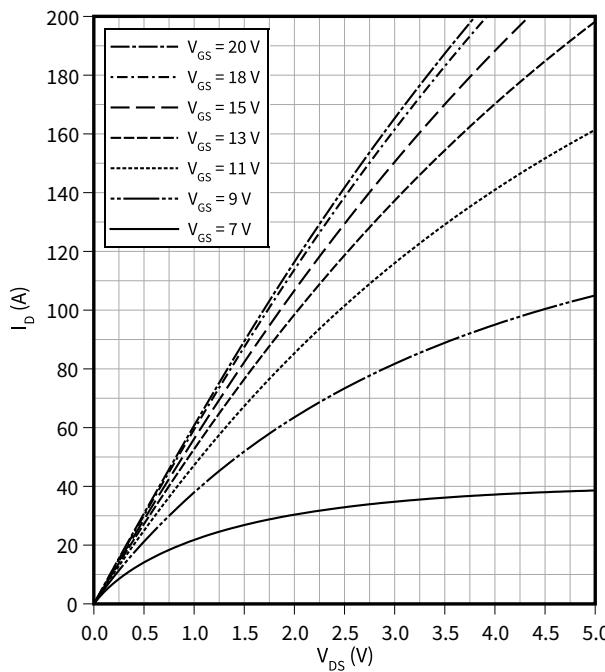


7 Characteristics diagrams

Output characteristic field (typical), MOSFET

$I_D = f(V_{DS})$

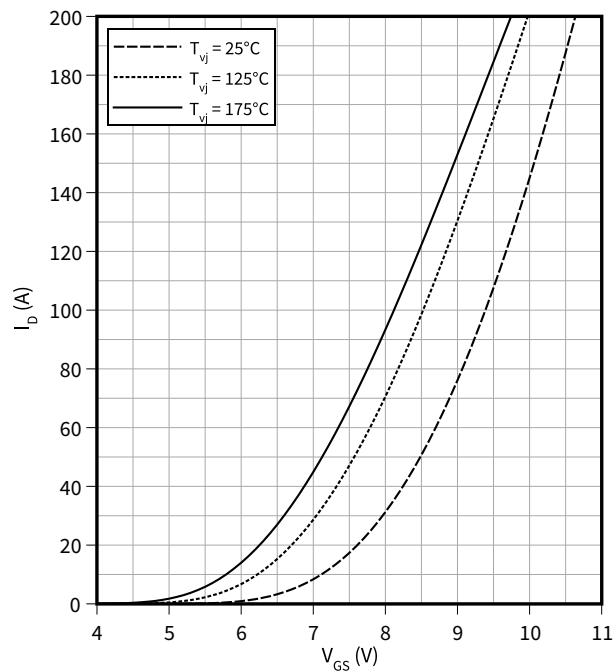
$T_{vj} = 175^\circ\text{C}$



Transfer characteristic (typical), MOSFET

$I_D = f(V_{GS})$

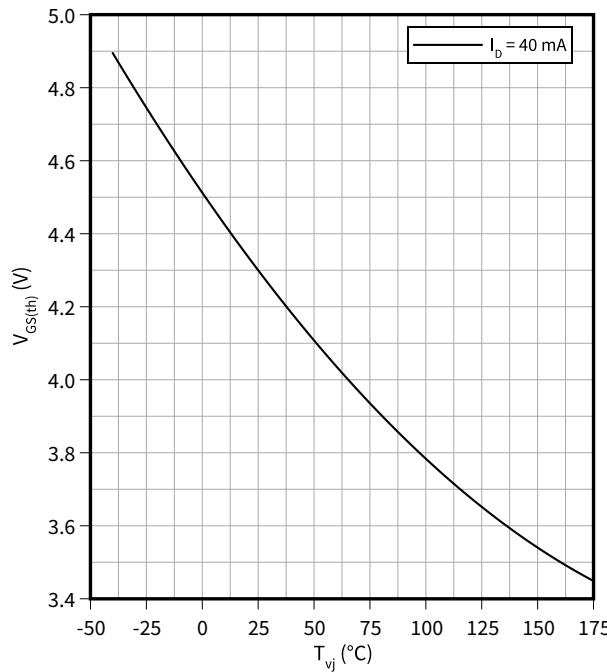
$V_{DS} = 20\text{ V}$



Gate-source threshold voltage (typical), MOSFET

$V_{GS(th)} = f(T_{vj})$

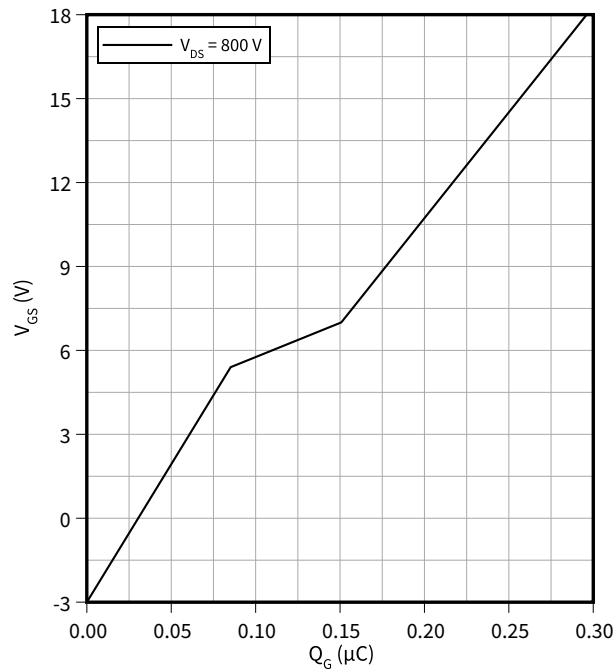
$V_{GS} = V_{DS}$



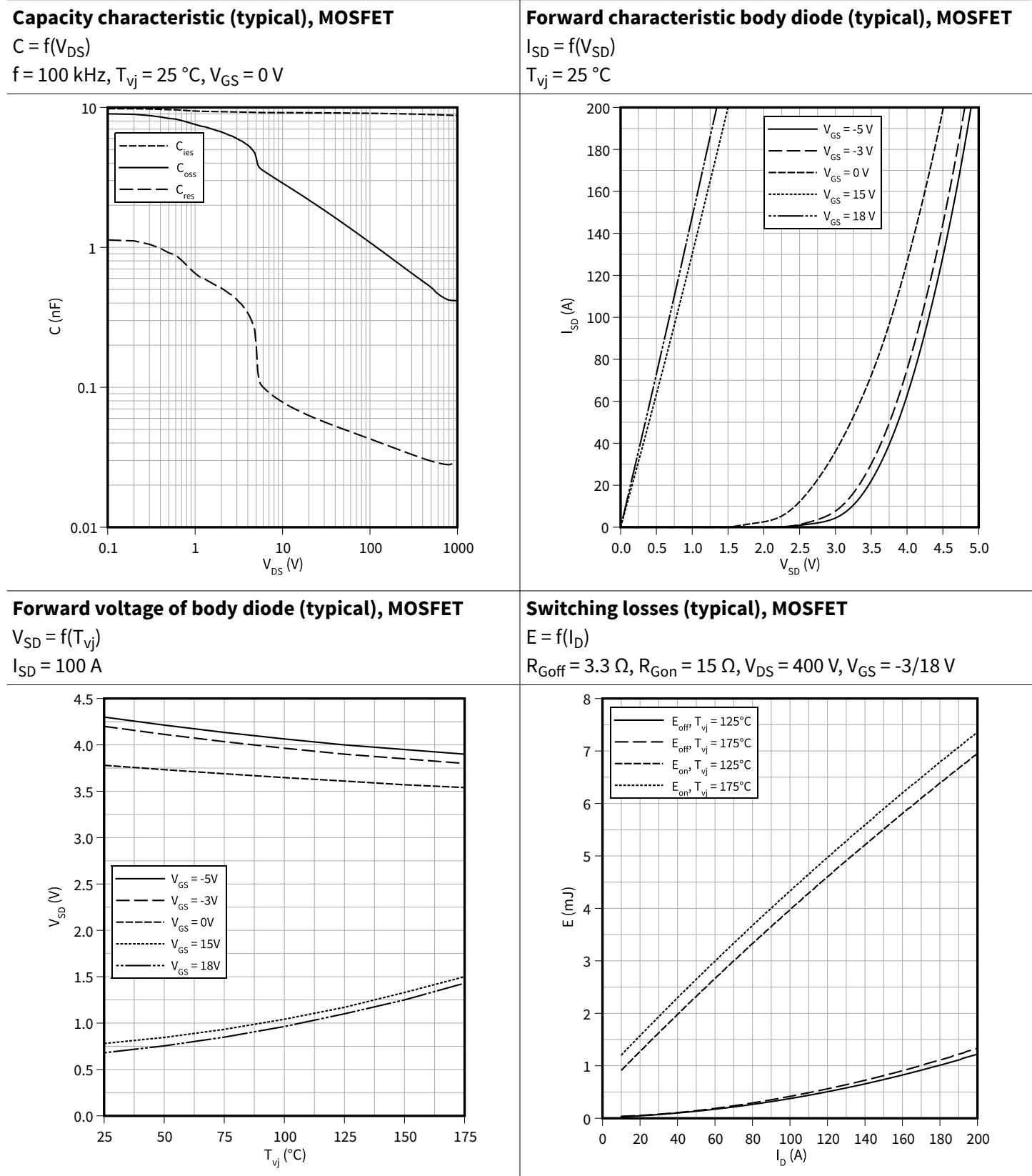
Gate charge characteristic (typical), MOSFET

$V_{GS} = f(Q_G)$

$I_D = 100\text{ A}, T_{vj} = 25^\circ\text{C}$



7 Characteristics diagrams

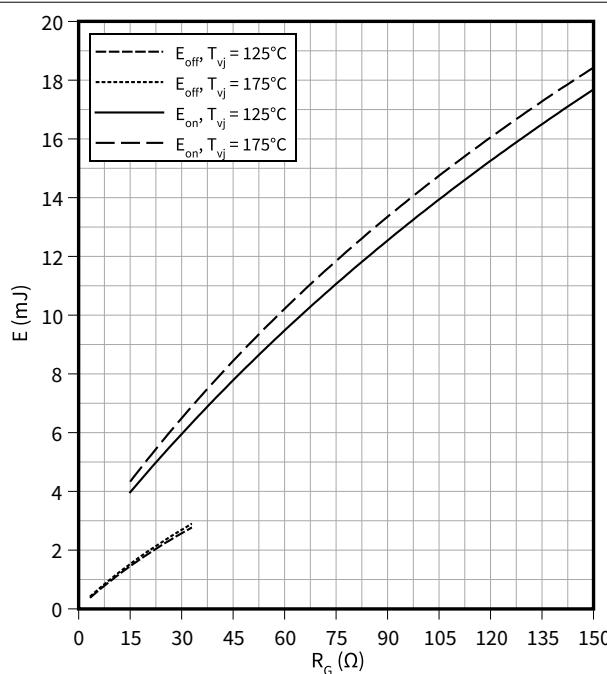


7 Characteristics diagrams

Switching losses (typical), MOSFET

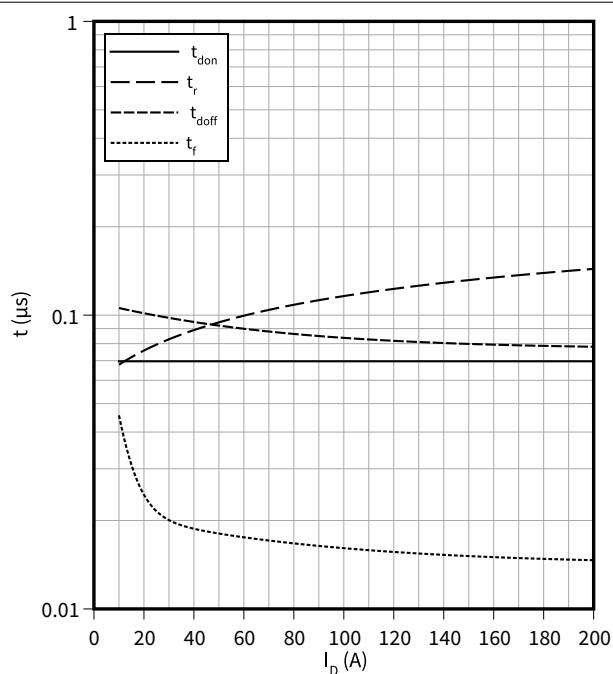
$$E = f(R_G)$$

$V_{DS} = 400 \text{ V}$, $I_D = 100 \text{ A}$, $V_{GS} = -3/18 \text{ V}$

**Switching times (typical), MOSFET**

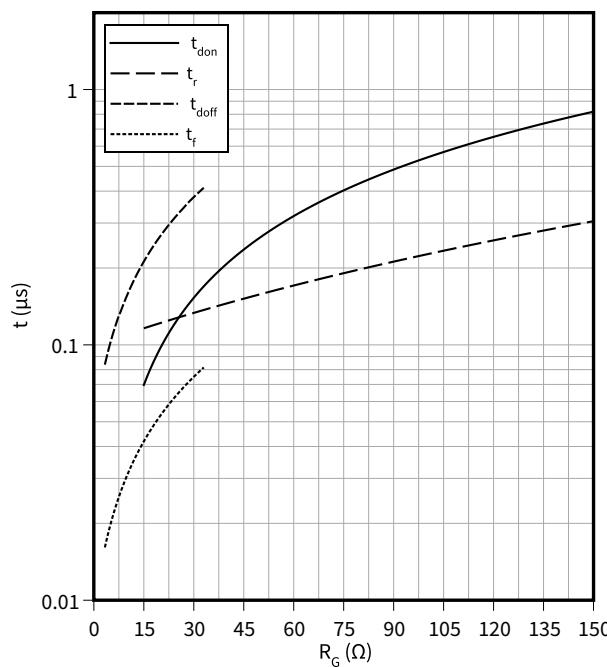
$$t = f(I_D)$$

$R_{Goff} = 3.3 \Omega$, $R_{Gon} = 15 \Omega$, $V_{DS} = 400 \text{ V}$, $T_{vj} = 175^\circ\text{C}$, $V_{GS} = -3/18 \text{ V}$

**Switching times (typical), MOSFET**

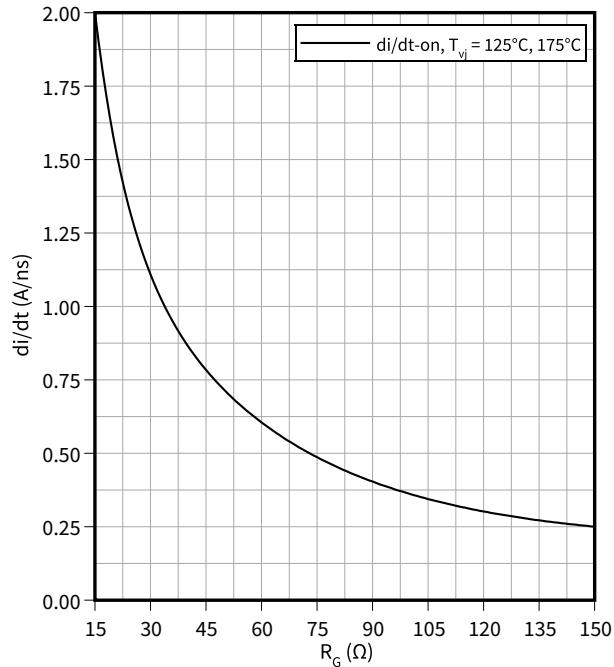
$$t = f(R_G)$$

$V_{DS} = 400 \text{ V}$, $I_D = 100 \text{ A}$, $T_{vj} = 175^\circ\text{C}$, $V_{GS} = -3/18 \text{ V}$

**Current slope (typical), MOSFET**

$$di/dt = f(R_G)$$

$V_{DS} = 400 \text{ V}$, $I_D = 100 \text{ A}$, $V_{GS} = -3/18 \text{ V}$

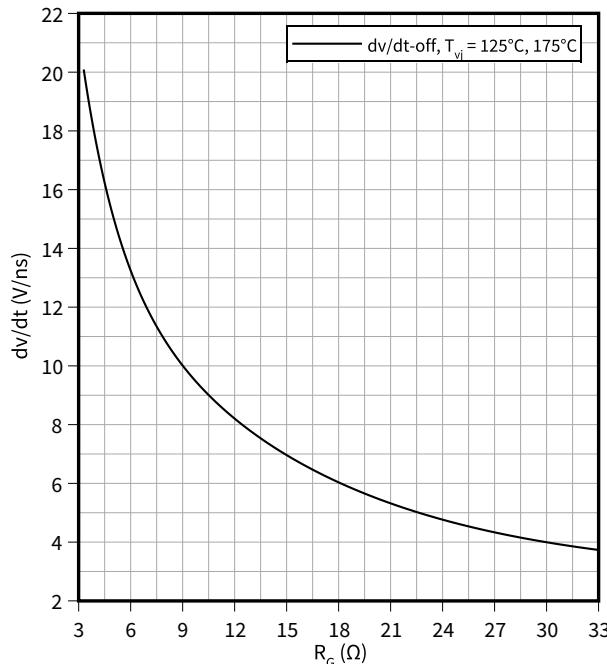


7 Characteristics diagrams

Voltage slope (typical), MOSFET

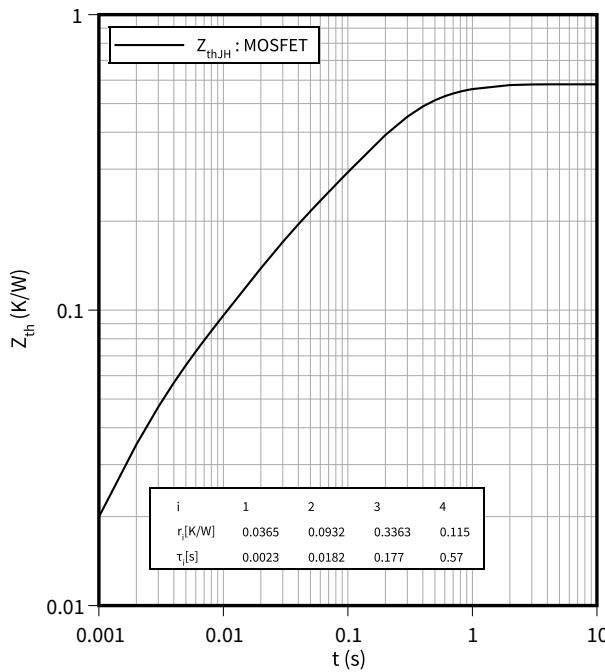
$$dv/dt = f(R_G)$$

$$V_{DS} = 400 \text{ V}, I_D = 100 \text{ A}, V_{GS} = -3/18 \text{ V}$$



Transient thermal impedance, MOSFET

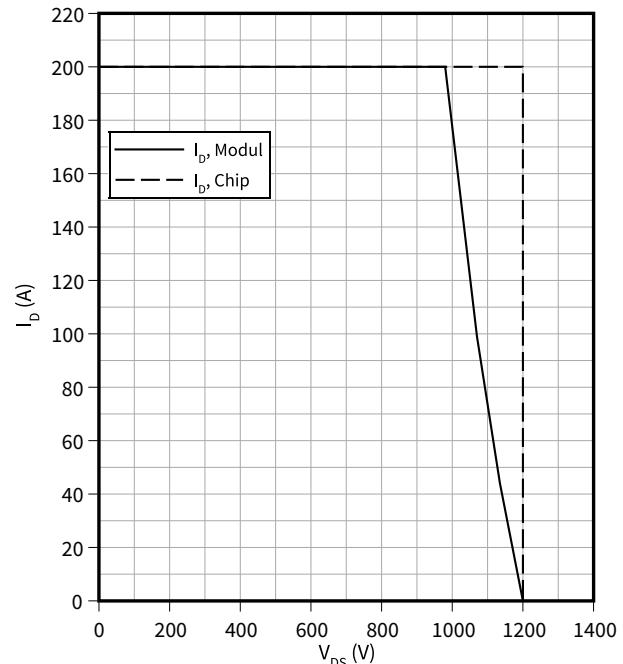
$$Z_{th} = f(t)$$



Reverse bias safe operating area (RBSOA), MOSFET

$$I_D = f(V_{DS})$$

$$R_{Goff} = 3.3 \Omega, T_{vj} = 175^\circ\text{C}, V_{GS} = -3/18 \text{ V}$$

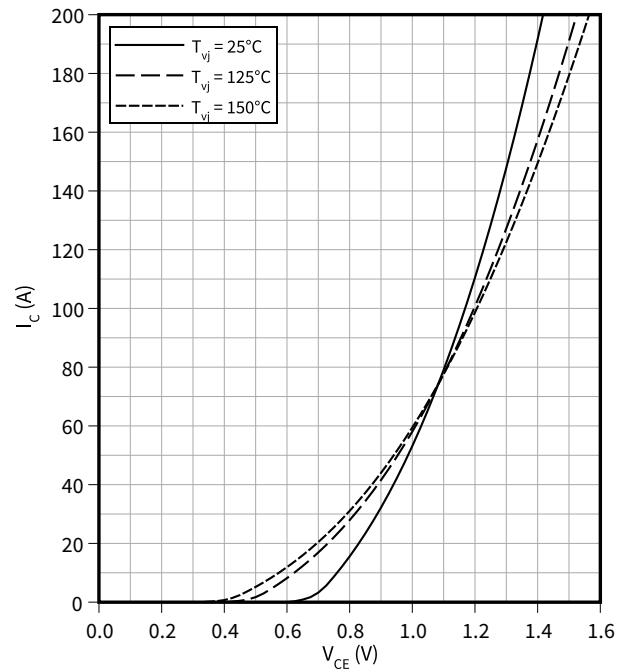


Output characteristic (typical), IGBT, 3-Level

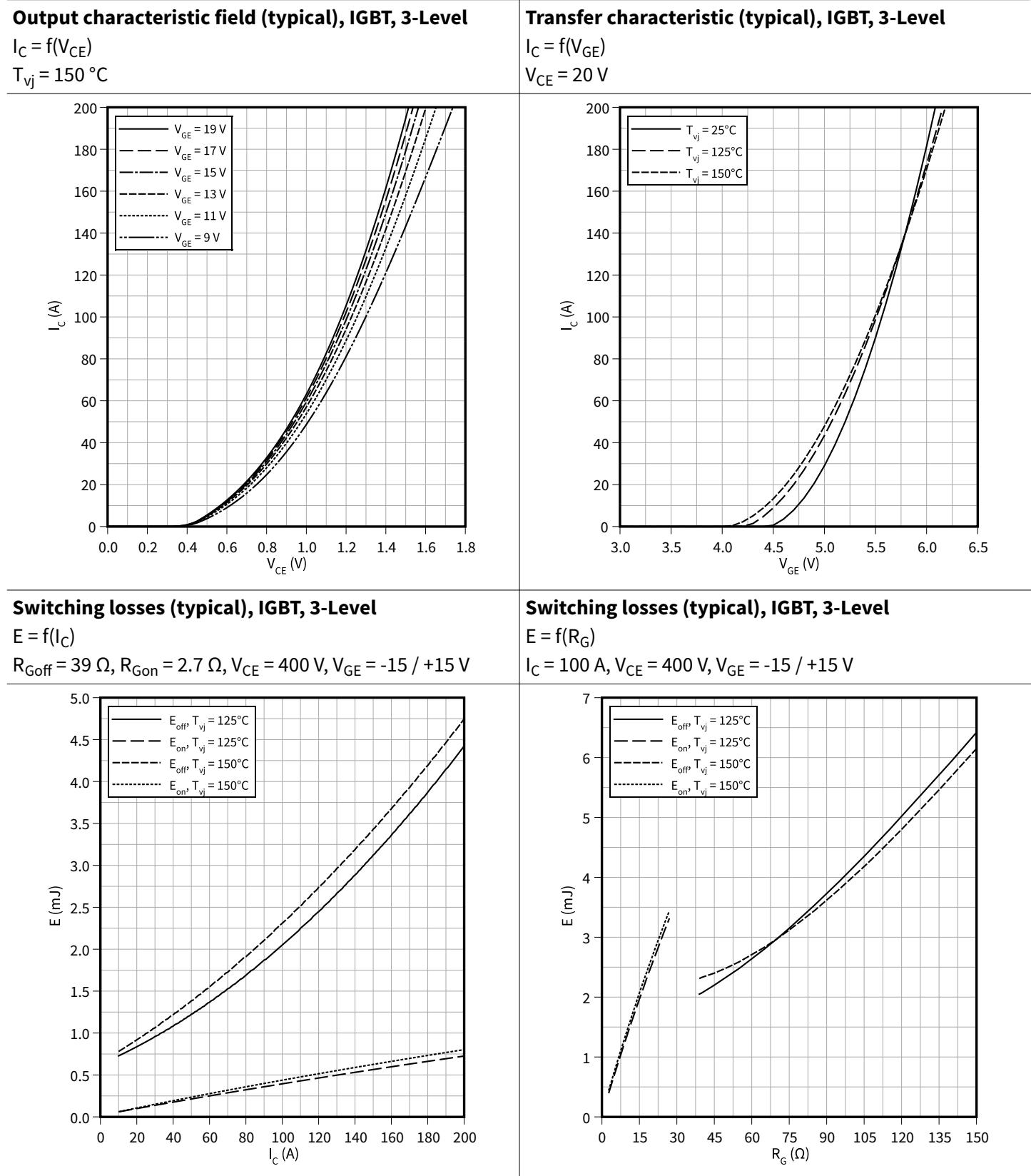
Output characteristic (typical), IGBT, 3-Level

$$I_C = f(V_{CE})$$

$$V_{GE} = 15 \text{ V}$$



7 Characteristics diagrams

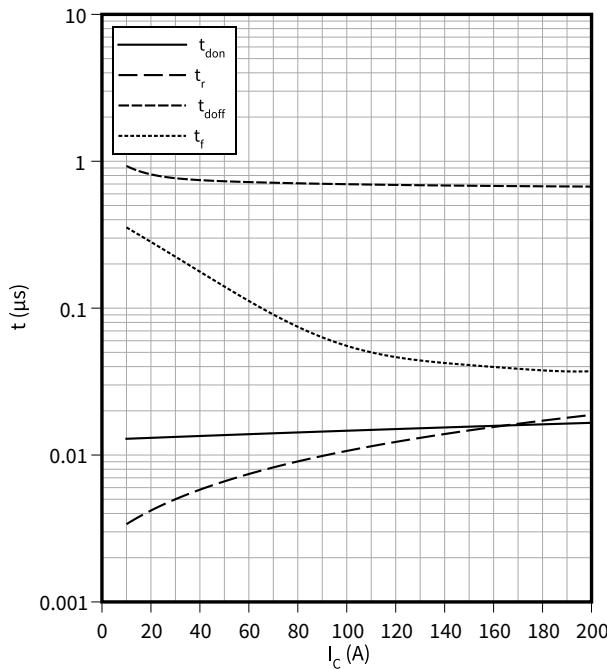


7 Characteristics diagrams

Switching times (typical), IGBT, 3-Level

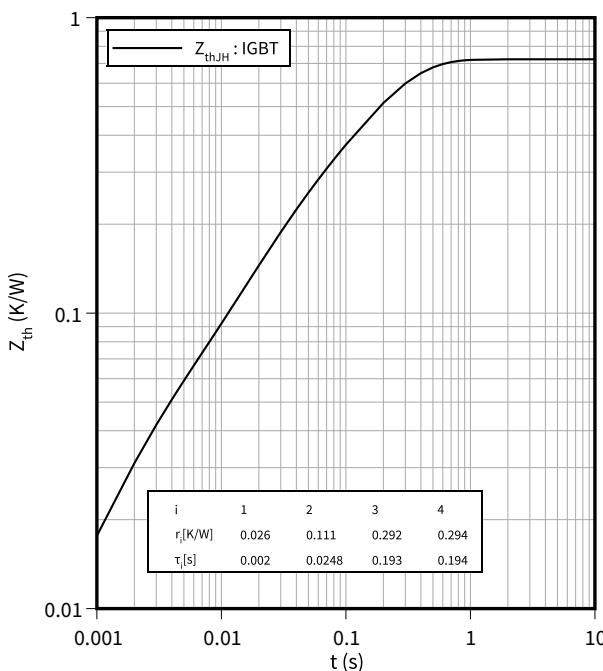
$$t = f(I_C)$$

$R_{Goff} = 39 \Omega$, $R_{Gon} = 2.7 \Omega$, $R_{Gon} = 2.7 \Omega$, $V_{CE} = 400 \text{ V}$, $V_{GE} = \pm 15 \text{ V}$, $T_{vj} = 150 \text{ }^\circ\text{C}$



Transient thermal impedance, IGBT, 3-Level

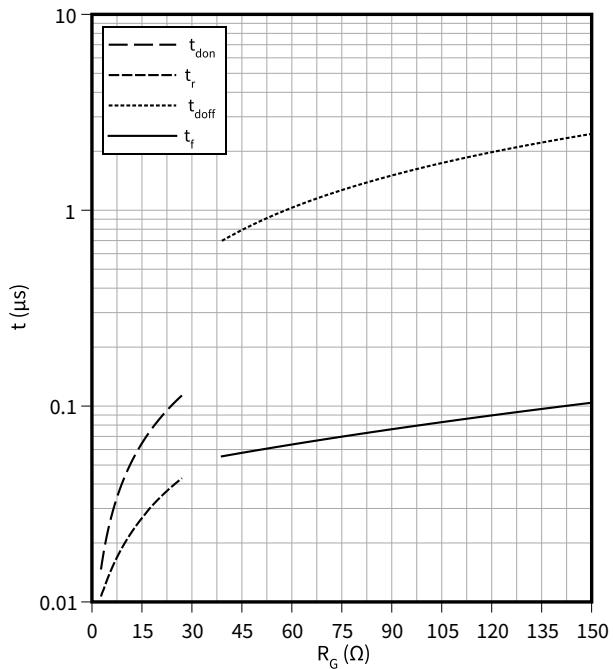
$$Z_{th} = f(t)$$



Switching times (typical), IGBT, 3-Level

$$t = f(R_G)$$

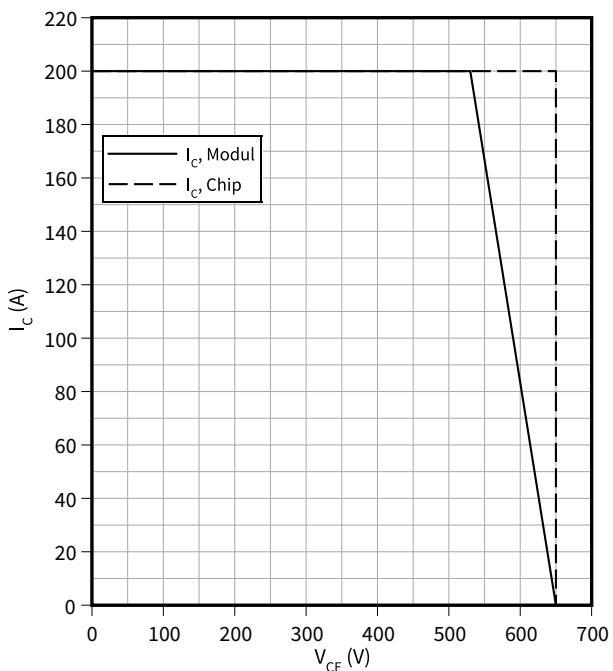
$I_C = 100 \text{ A}$, $V_{CE} = 400 \text{ V}$, $V_{GE} = -15 / +15 \text{ V}$, $T_{vj} = 150 \text{ }^\circ\text{C}$



Reverse bias safe operating area (RBSOA), IGBT, 3-Level

$$I_C = f(V_{CE})$$

$T_{vj} = 150 \text{ }^\circ\text{C}$, $R_{Goff} = 39 \Omega$, $V_{GE} = \pm 15 \text{ V}$

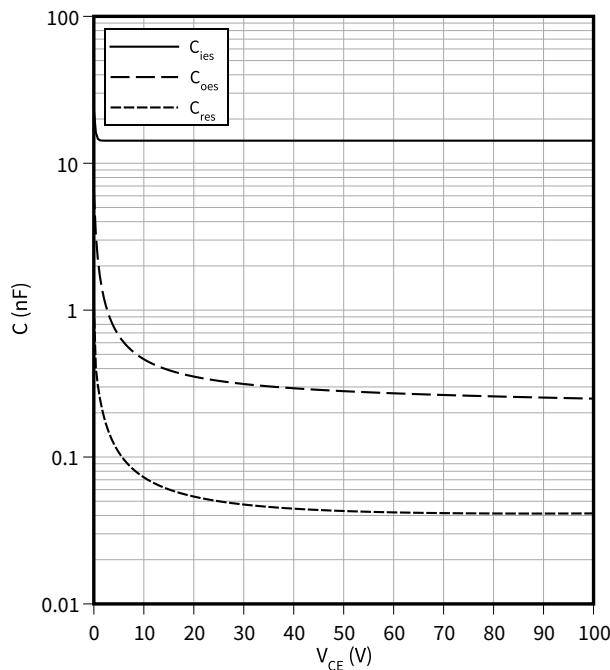


7 Characteristics diagrams

Capacity characteristic (typical), IGBT, 3-Level

$$C = f(V_{CE})$$

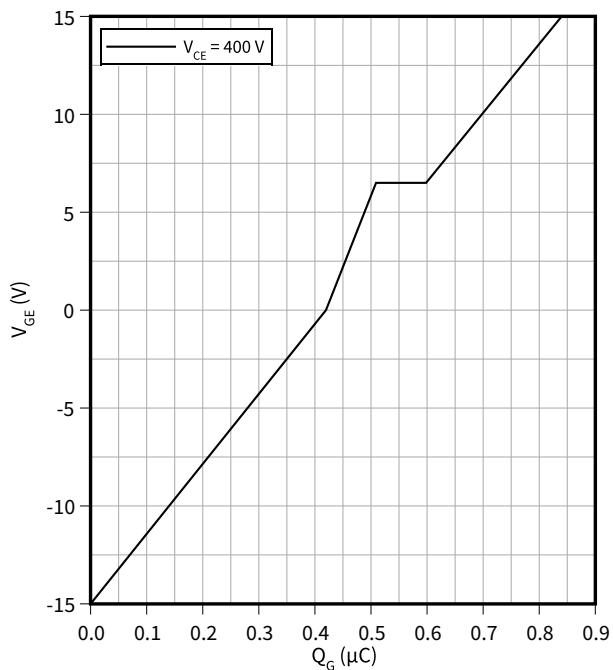
$$f = 100 \text{ kHz}, V_{GE} = 0 \text{ V}, T_{vj} = 25^\circ\text{C}$$



Gate charge characteristic (typical), IGBT, 3-Level

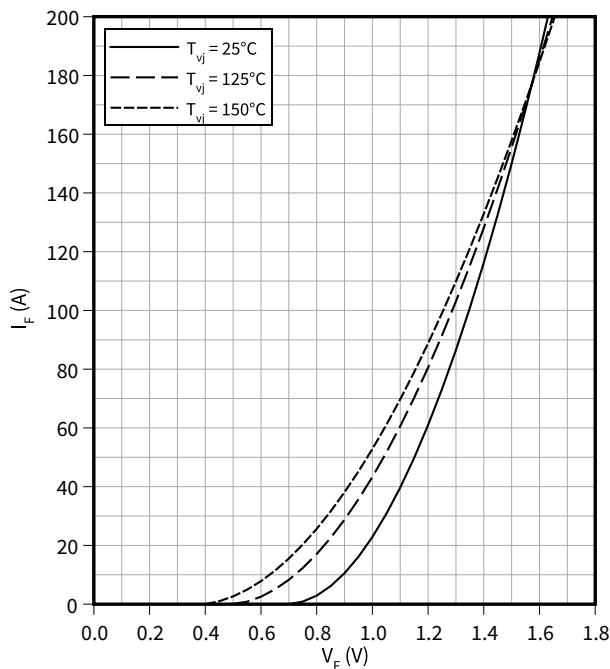
$$V_{GE} = f(Q_G)$$

$$I_C = 100 \text{ A}, T_{vj} = 25^\circ\text{C}$$



Forward characteristic (typical), Diode, 3-Level

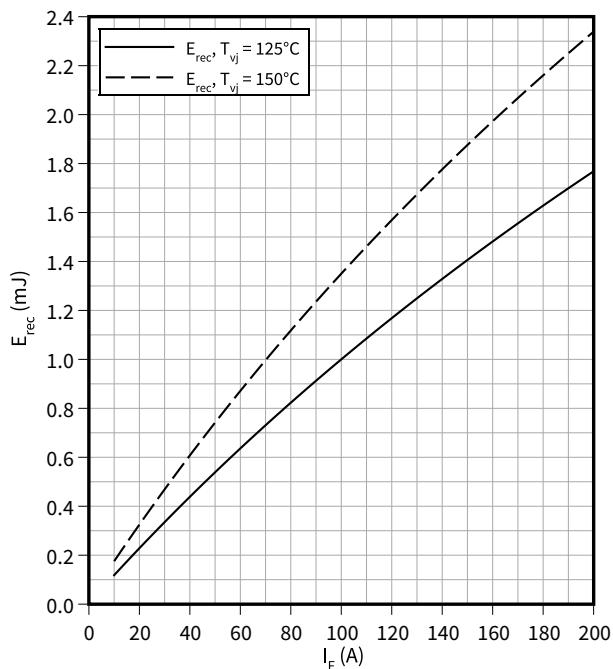
$$I_F = f(V_F)$$



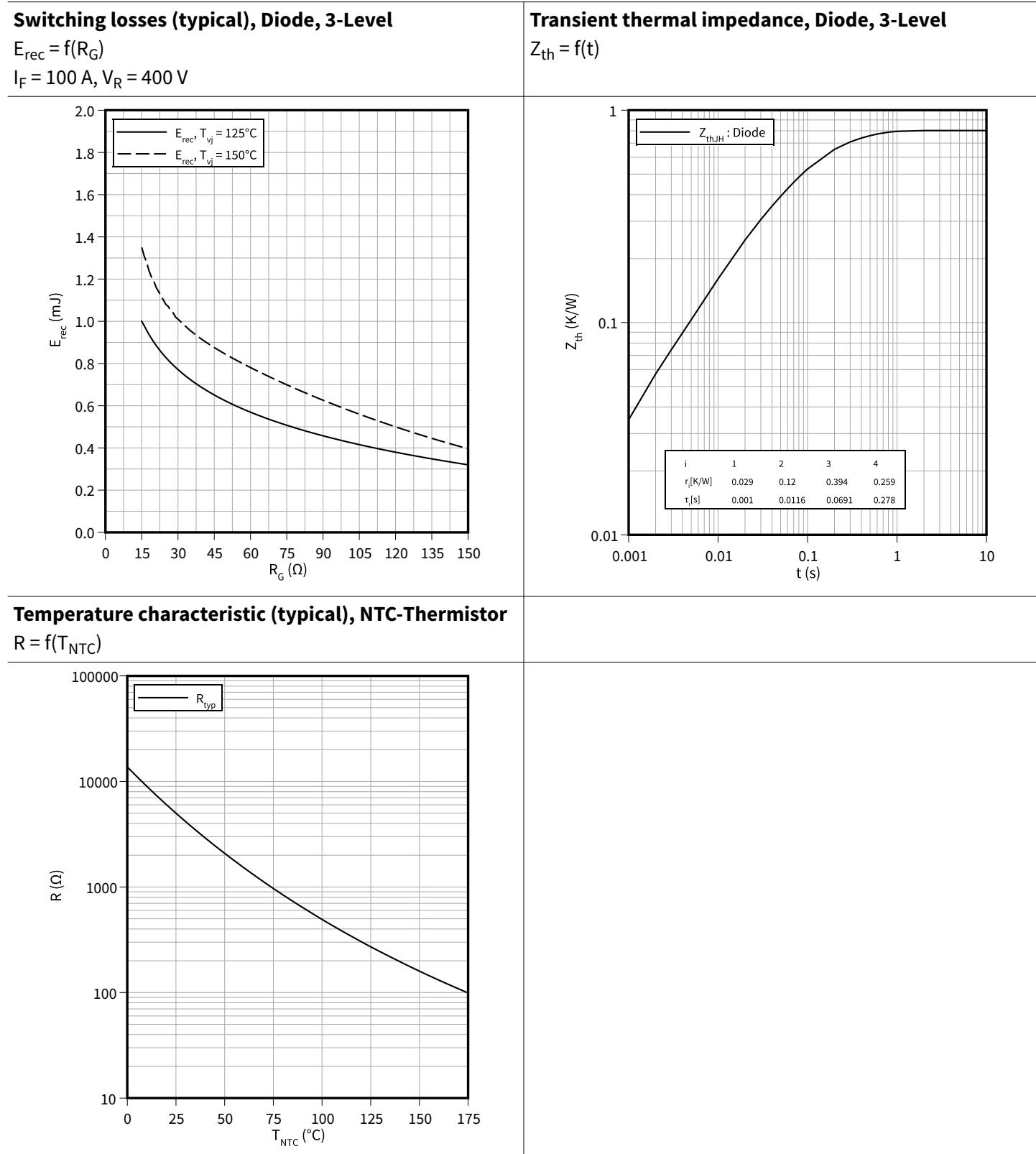
Switching losses (typical), Diode, 3-Level

$$E_{rec} = f(I_F)$$

$$R_G = 15 \Omega, V_R = 400 \text{ V}$$



7 Characteristics diagrams



8 Circuit diagram

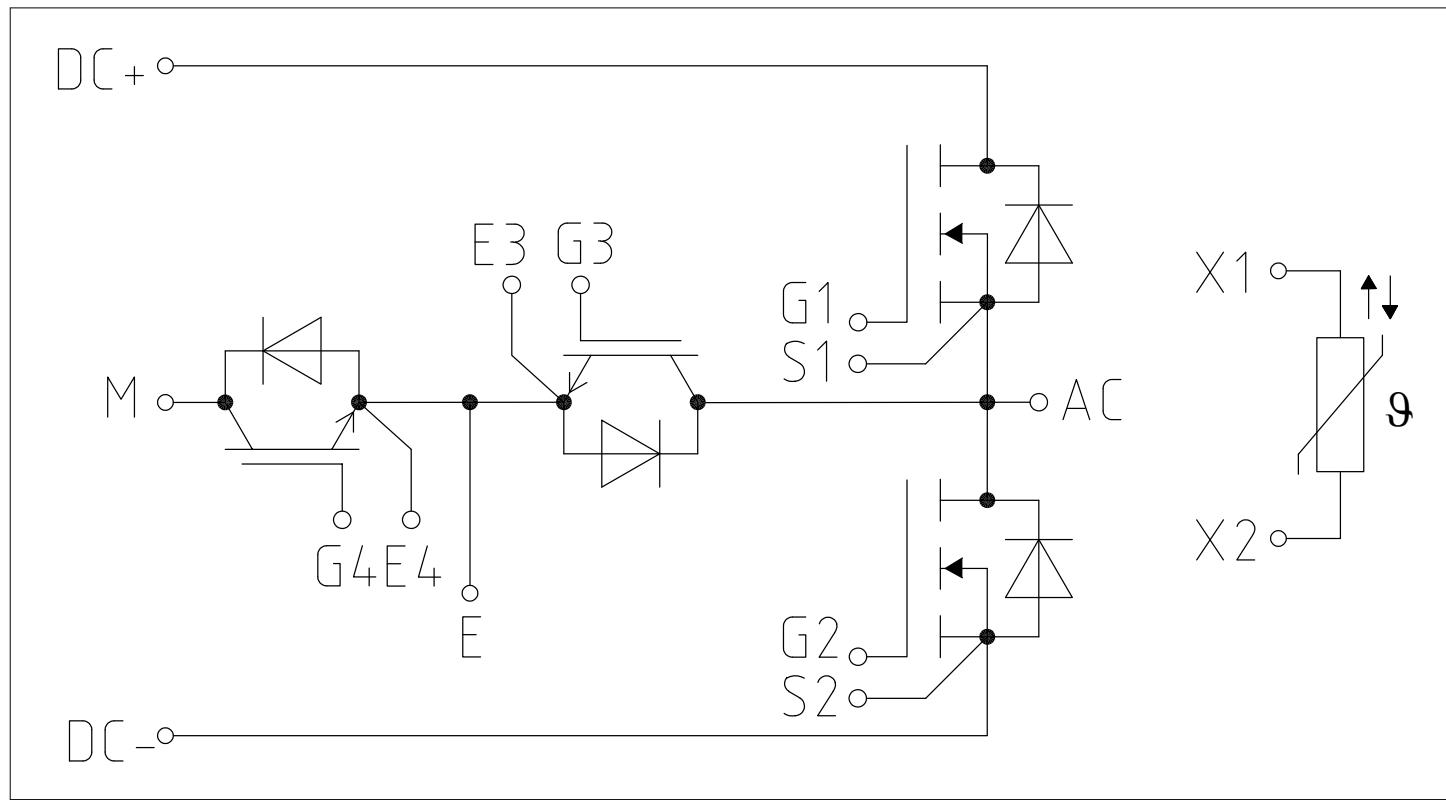


Figure 1

9 Package outlines

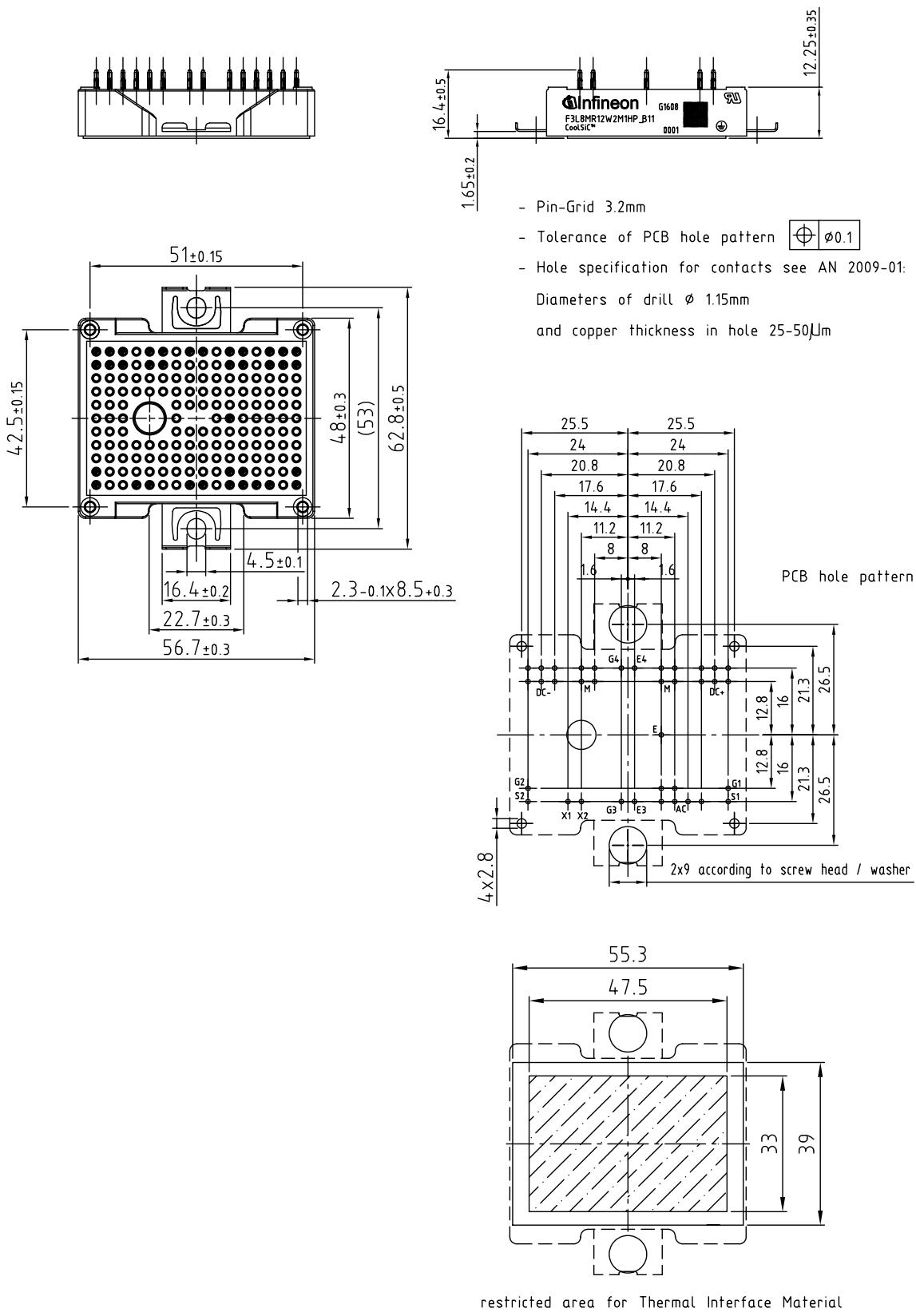


Figure 2

10**Module label code**

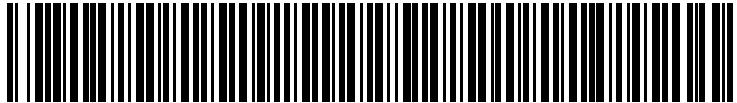
Module label code			
Code format	Data Matrix		Barcode Code128
Encoding	ASCII text		Code Set A
Symbol size	16x16		23 digits
Standard	IEC24720 and IEC16022		IEC8859-1
Code content	<p><i>Content</i></p> <p>Module serial number Module material number Production order number Date code (production year) Date code (production week)</p>	<p><i>Digit</i></p> <p>1 – 5 6 - 11 12 - 19 20 – 21 22 – 23</p>	<p><i>Example</i></p> <p>71549 142846 55054991 15 30</p>
Example			71549142846550549911530

Figure 3

Revision history

Revision history

Document revision	Date of release	Description of changes
0.10	2021-04-07	
1.00	2022-03-09	Final datasheet
1.10	2022-03-10	Final datasheet

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IFX-ABA497-003**

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